RENESAS

MOS FIELD EFFECT POWER TRANSISTOR

Phase-out/Discontinued

2SK1760

SWITCHING
N-CHANNEL POWER MOS FET
INDUSTRIAL USE

DESCRIPTION

The 2SK1760 is N-channel MOS Field Effect Transistor designed for high voltage switching applications.

FEATURES

- Low On-state Resistance
  $R_{DS(on)} \leqq 4.0\ \Omega$ (V_{GS} = 10 V, I_D = 3 A)
- Low C_{iss} C_{iss} = 790 pF TYP.
- Built-in G-S Gate Protection Diode
- High Avalanche Capability Ratings

QUALITY GRADE

Standard

Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

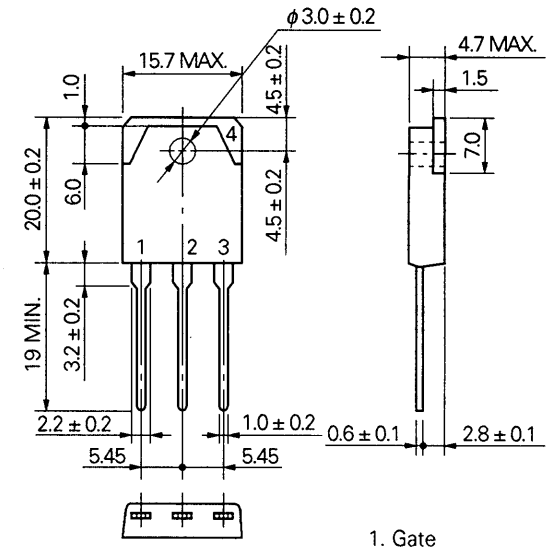
ABSOLUTE MAXIMUM RATINGS (T_a = 25 °C)

Drain to Source Voltage	V_{DSS}	900	V
Gate to Source Voltage	V_{GSS}	±30	V
Drain Current (DC)	$I_{D(DC)}$	±5.0	A
Drain Current (pulse)	$I_{D(pulse)}$*	±10	A
Total Power Dissipation (T_C = 25 °C)	P_T	100	W
Channel Temperature	T_{ch}	150	°C
Storage Temperature	T_{stg}	−55 to +150	°C

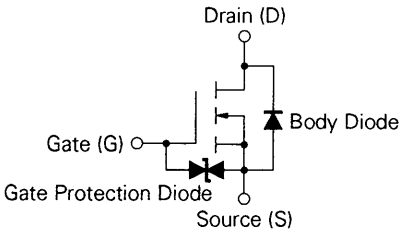
* PW ≦ 10 μs, Duty Cycle ≦ 1 %

PACKAGE DIMENSIONS

(in millimeters)



1. Gate
2. Drain
3. Source
4. Fin (Drain)

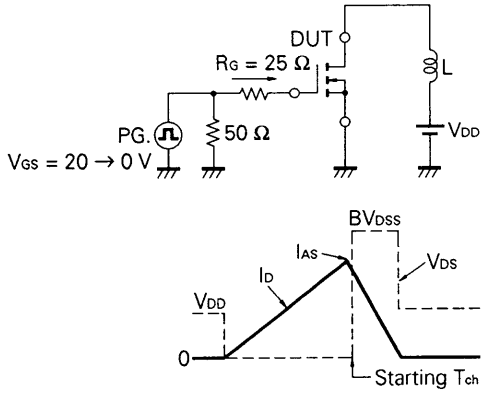


Document No. TC-2437
Date Published August 1993 M
Printed in Japan

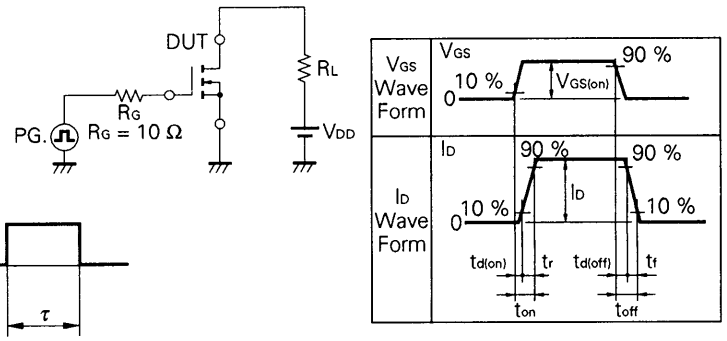
ELECTRICAL CHARACTERISTICS (T_a = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain to Source On-state Resistance	$R_{DS(on)}$		3.1	4.0	Ω	V_{GS} = 10 V, I_D = 3 A
Gate to Source Cutoff Voltage	$V_{GS(off)}$	2.5		3.5	V	V_{DS} = 10 V, I_D = 1 mA
Forward Transfer Admittance	$\|y_{fs}\|$	1.0	3.1		S	V_{DS} = 20 V, I_D = 3 A
Drain Leakage Current	I_{DSS}			100	μA	V_{DS} = 900 V, V_{GS} = 0
Gate to Source Leakage Current	I_{GSS}			±10	μA	V_{GS} = ±30 V, V_{DS} = 0
Input Capacitance	C_{iss}		790		pF	V_{DS} = 10 V V_{GS} = 0 f = 1 MHz
Output Capacitance	C_{oss}		150		pF	
Reverse Transfer Capacitance	C_{rss}		60		pF	
Turn-On Delay Time	$t_{d(on)}$		15		ns	V_{GS} = 10 V V_{DD} = 150 V I_D = 3 A, R_G = 10 Ω R_L = 50 Ω
Rise Time	t_r		30		ns	
Turn-Off Delay Time	$t_{d(off)}$		80		ns	
Fall Time	t_f		25		ns	
Total Gate Charge	Q_G		34		nC	V_{GS} = 10 V I_D = 5 A V_{DD} = 450 V
Gate to Source Charge	Q_{GS}		6		nC	
Gate to Drain Charge	Q_{GD}		18		nC	
Diode Forward Voltage	$V_{F(S-D)}$		0.9		V	I_F = 5 A, V_{GS} = 0
Reverse Recovery Time	t_{rr}		660		ns	I_F = 5 A, V_{GS} = 0 di/dt = 50 A/μs
Reverse Recovery Charge	Q_{rr}		4.5		μC	
Single Avalanche Current	I_{AS}			5.0	A	V_{DD} = 150 V, L = 100 μH R_G = 25 Ω, V_{GS} = 20 V → 0 Unclamped Starting T_{ch} = 25 °C

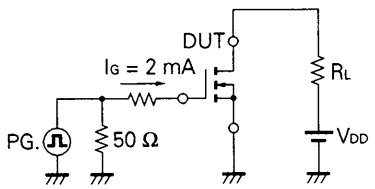
Test Circuit 1: Avalanche Capability



Test Circuit 2: Switching Time

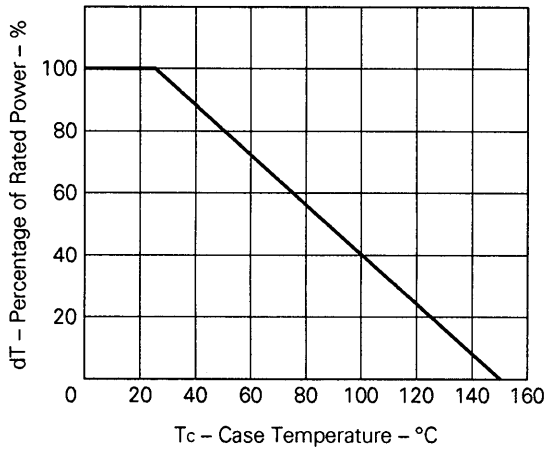


Test Circuit 3: Gate Charge

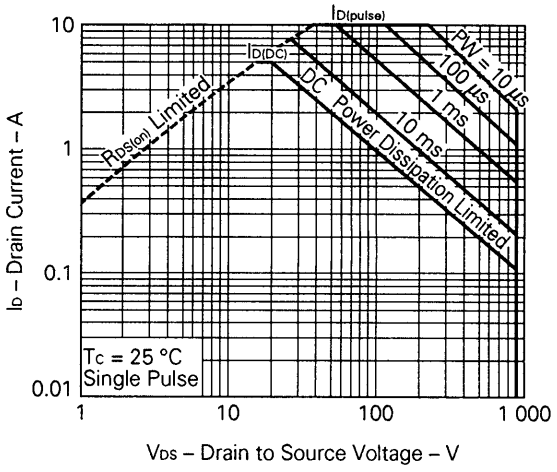


TYPICAL CHARACTERISTICS (T_a = 25 °C)

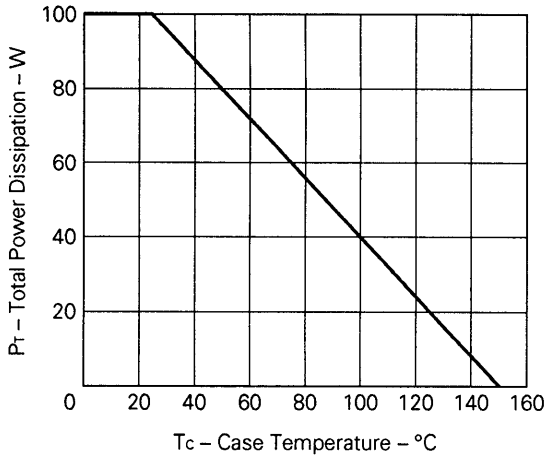
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



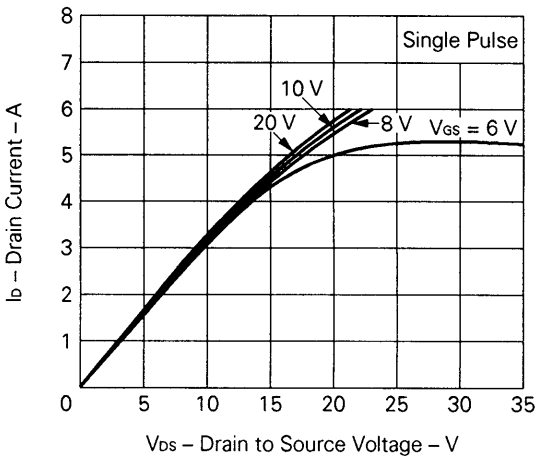
FORWARD BIAS SAFE OPERATING AREA



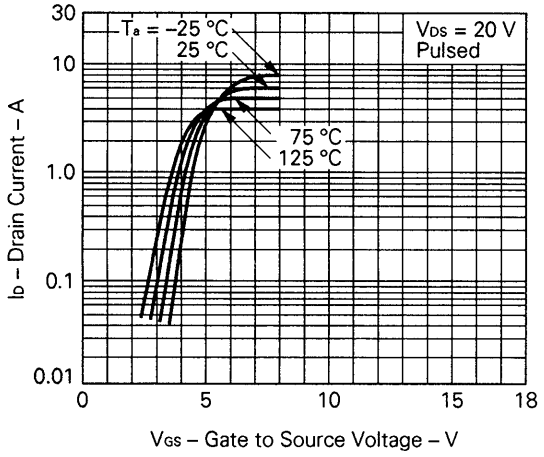
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



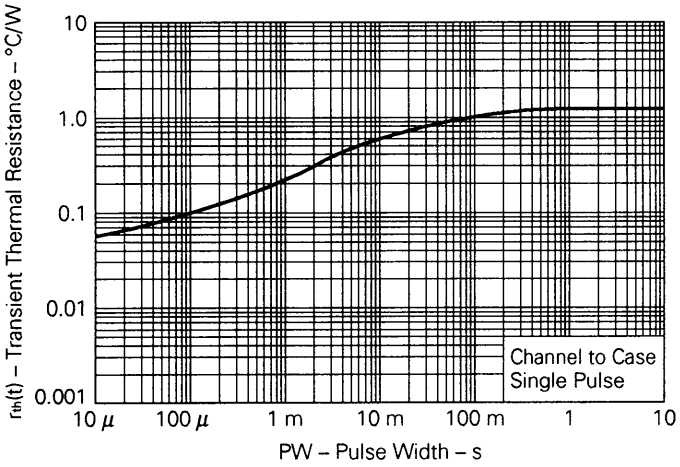
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



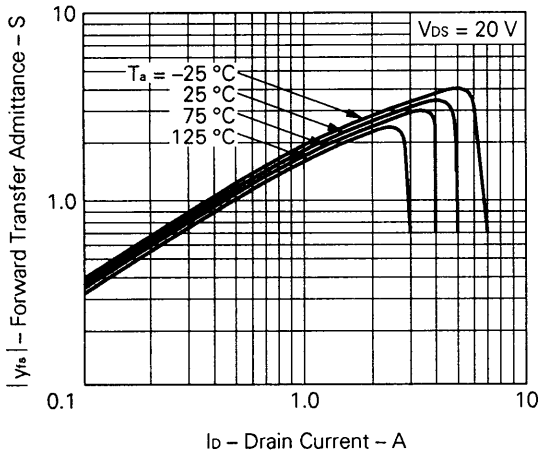
TRANSFER CHARACTERISTICS



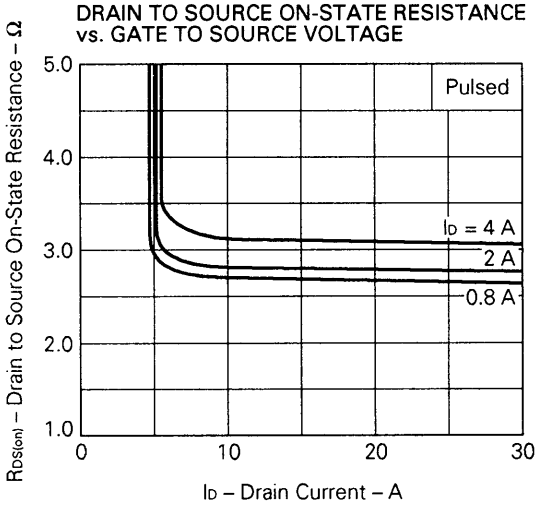
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



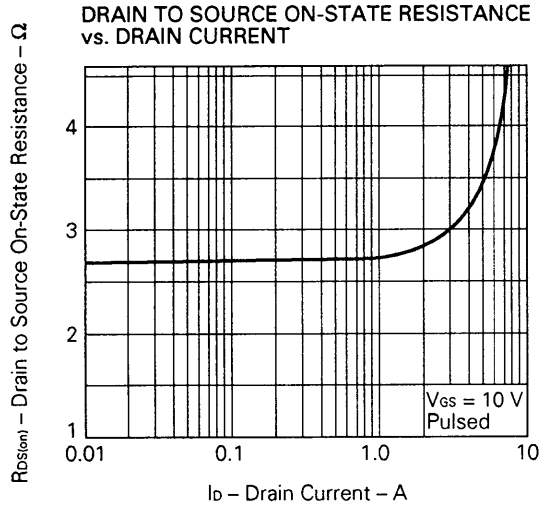
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



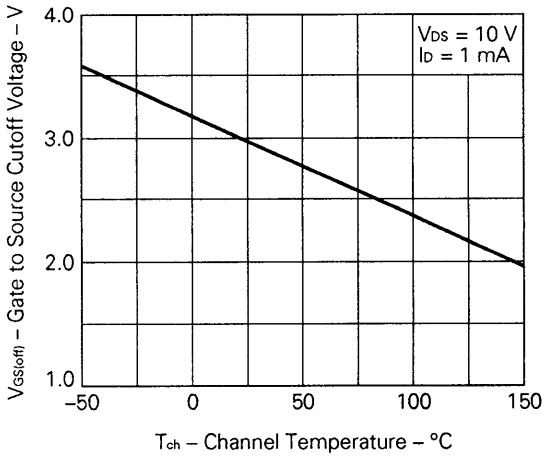
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



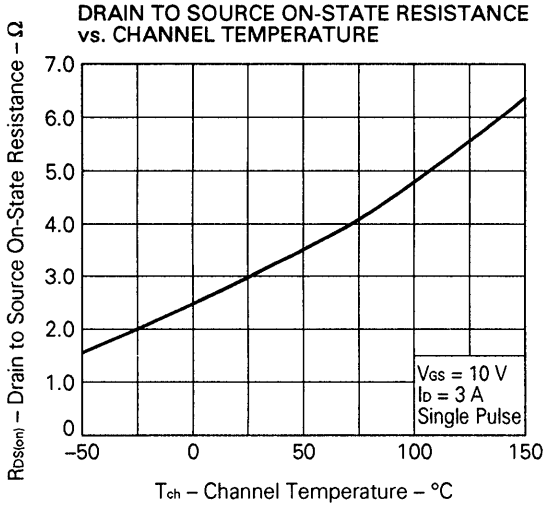
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



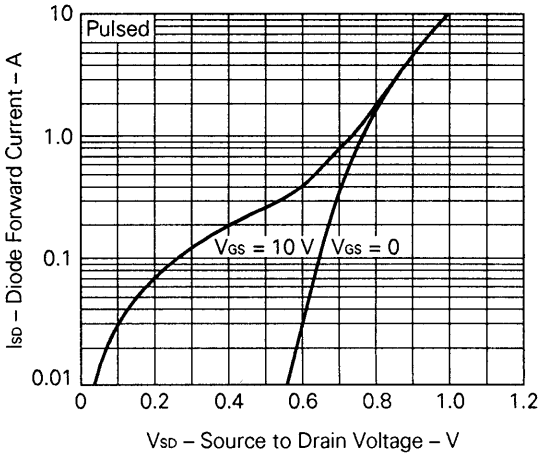
GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE



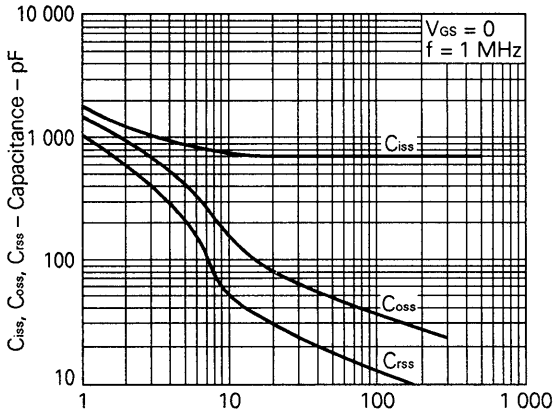
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



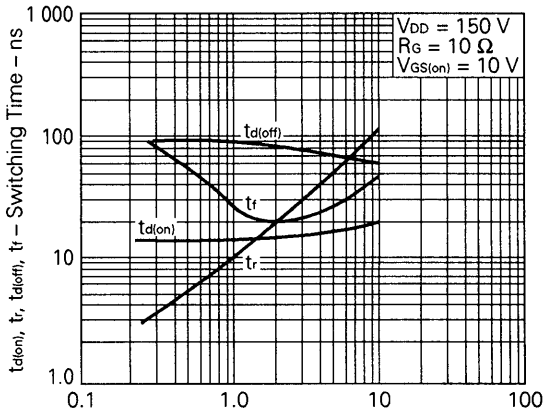
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



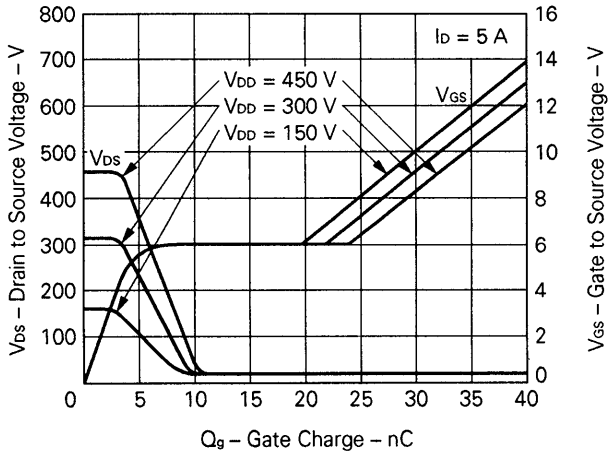
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SWITCHING TIME vs. DRAIN CURRENT



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



REVERSE RECOVERY TIME vs. REVERSE DRAIN CURRENT